

## Electronic Supporting Information

# Aggregation-Induced Emission (AIE) Organic Metal Halide Complex for X-ray Scintillation

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## Experimental Section

Materials: Zinc Chloride (99.999%), 4-bromotriphenylamine (97%), pyridine-4-boronic acid (90%), tetrakis(triphenylphosphine)-palladium(0),(99%), potassium carbonate (≥99.0%), tetrahydrofuran (THF, ≥99.9%), methanol (MeOH, ≥99.9%), dichloromethane (DCM, ≥99.8%), poly methylmethacrylate (average molecular weight- 120, 000) were all purchased from Sigma Aldrich. N, N-Dimethylformamide (DMF ≥99.8%), and diethyl ether (Et<sub>2</sub>O, ≥99.9%) were purchased from VWR. These materials were used without further purification after purchase. The elemental analysis was performed by Atlantic Microlab, Inc., Norcross, Georgia, USA.

Synthesis of N, N-diphenyl-4-(pyridin-4-yl) aniline (TPA-PD): 4-Bromotriphenylamine (7.4 mmol, 324.21 g/mol, 2.4 g), pyridine-4-boronic acid (12 mmol, 122.92 g/mol, 1.475 g), tetrakis(triphenylphosphine)-palladium(0) (0.297 mmol, 1155 g/mol, 0.344 g) and potassium carbonate (14.4 mmol, 138.21 g/mol, 2 g) were weighed into clean flask. This was followed by three cycles of repeated purging with N<sub>2</sub> and vacuum evacuation. A 120 ml of combined solvent (THF: MeOH; 1:1) of THF and MeOH was added with two cycles of purging with N<sub>2</sub> and vacuum evacuation. The mixture was refluxed at 90 °C for 36 hours under an N<sub>2</sub> atmosphere and then concentrated by rotary evaporation. TPA-PD was purified by column chromatography on silica gel with a mixture of petroleum ether and ethyl acetate as the eluent (7:1 by volume) to obtain about 55% TPA-PD white solid yield after recrystallization with DCM. <sup>1</sup>H NMR (600 MHz, DMF-D7) δ 8.65 - 8.61 (m, 2H), 7.82 (d, J = 8.7 Hz, 2H), 7.75 - 7.71 (m, 2H), 7.44 - 7.37 (m, 4H), 7.19 - 7.13 (m, 6H), 7.11 (d, J = 8.7 Hz, 2H).; HRMS (ESI) m/z: calc. value: 322.15; found 323.1567. Elemental analysis for TPA-PD (C<sub>23</sub>H<sub>18</sub>N<sub>2</sub>) calculated: C, 85.68; H, 5.63; N, 8.69. Found C, 84.86; H, 5.58; N, 8.69.

Synthesis of N,N-diphenyl-4-(pyridine-4-yl)aniline zinc (II) chloride (TPA-PD)<sub>2</sub>ZnCl<sub>2</sub>: 2:1 molar ratio of N,N-diphenyl-4-(pyridine-4-yl)aniline and zinc chloride were fully dissolved in the appropriate amount of DMF to form a precursor solution. This was followed by the addition of acetonitrile, 3× the volume of the precursor solution. Crystal formation of (TPA-PD)<sub>2</sub>ZnCl<sub>2</sub> within a few hours to a day is observed. This is followed by

washing with Et<sub>2</sub>O, achieving about 87% yield of (TPA-P)<sub>2</sub>ZnCl<sub>2</sub>. <sup>1</sup>H NMR (600 MHz, DMF-D7) δ 8.69 – 8.65 (m, 2H), 7.90 – 7.84 (m, 4H), 7.41 (dd, J = 8.4, 7.5 Hz, 4H), 7.17 (ddd, J = 3.7, 3.0, 1.3 Hz, 6H), 7.11 (d, J = 8.8 Hz, 2H). Elemental analysis for (TPA-PD)<sub>2</sub>ZnCl<sub>2</sub> (C<sub>46</sub>H<sub>36</sub>N<sub>4</sub>ZnCl<sub>2</sub>); Calculated: C, 70.73; H, 4.65; N, 7.17; Cl, 9.08. Found: C, 70.50; H, 4.65; N, 7.42; Cl, 9.09.

Fabrication of X-ray imaging scintillator film: 120 mg of (TPA-PD)<sub>2</sub>ZnCl<sub>2</sub> crystals were initially partially dissolved in 0.5 ml of chloroform. To ensure thorough mixing, the solution was vortex-mixed and sonicated for 2 hours. Following the dissolution of the crystals, 80 mg of poly(methyl methacrylate) (PMMA) was added to the solution. This mixture was then subjected to an additional 2 hours of sonication. Once this step was complete, the resulting solution was further stirred using a magnetic stirrer for 30 minutes. To prepare the substrate for film deposition, an ozone-cleaned glass surface was utilized. The well-mixed and homogenized slurry was carefully drop-cast onto the glass substrate and allowed to dry for 24 hours. It is noteworthy that during the drying process, a beaker housing was used to cover the substrate. This precaution was taken to ensure the film's uniformity and quality.

### Structural Characterization

Single-crystal X-ray data for (TPA-P)<sub>2</sub>ZnCl<sub>2</sub> was collected using a Rigaku XtaLAB Synergy-S diffractometer equipped with a HyPix-6000HE Hybrid Photon Counting (HPC) detector and dual Mo and Cu microfocus sealed X-ray source at 150 K. The powder X-ray diffraction (XRD) patterns were obtained using a Rigaku Smartlab powder diffractometer equipped with a Cu Kα X-ray source. Diffraction patterns were recorded from 5° to 50° 2θ with a step size of 0.05° under a tube current of 44 mA and tube voltage of 40 kV at room temperature. Further structural analysis of TPA-PD was done using <sup>1</sup>H B500 NMR equipped with a high-resolution 5 mm TXI (H-C/N-D) Zg probe. Mass spectrometry was performed using liquid chromatography- time-of-flight/mass spectrometry (LC-TOF/MS) (TOF 6230, LC 1260, Agilent) in a positive electrospray ionization (ESI) mode with a mass range of 100 – 1700 m/z.

### Optical Characterization

Excitation and steady-state photoluminescence were carried out using an Edinburgh FS5 steady state spectrometer with a 150 W xenon lamp. Time-Correlated Single Photon Counting (TCSPC) was performed for 10,000 counts using excitation from an Edinburgh EPL-360 picosecond pulsed diode laser. The PL decay was fitted using a biexponential decay function for TPA-PD and (TPA-PD)<sub>2</sub>ZnCl<sub>2</sub> and a mono-exponential decay function for BBPZn. The weighted average lifetime was computed according to equation (1).

$$\tau_{avg} = \frac{\sum \alpha_i \tau_i^2}{\sum \alpha_i \tau_i} \dots \dots \dots (1)$$

where τ<sub>i</sub> represents the decay time, and α<sub>i</sub> represents the amplitude of each component. PLQY measurement was performed using Hamamatsu Quantaurus-QY Spectrometer (Model C11347-11) equipped with a xenon lamp, an integrating sphere sample chamber, and a CCD detector. The PLQYs were calculated using the equation;

$$\eta QE = \frac{I_s}{ES_R - ES_s} \dots\dots\dots(2)$$

Where  $I_s$  stands for the photoluminescence emission spectrum of the sample, and  $ES_s$  and  $ES_R$  represent the excitation spectrum for the sample and reference, respectively.

**Thermal Stability Analysis**

DSC studies were done using a TA instrument Q600 system. The sample was heated from room temperature to 700 °C at a 5 °C/min rate under an argon flux of 100 mL/min.

**Radioluminescence Spectrum**

The RL spectra were acquired using an Edinburgh FS5 spectrofluorometer (Edinburgh Instruments) equipped with an X-ray source (Moxtek Mini-X tube with a W target and 4 W maximum power output, see Table S5 for voltage, current X-ray dose relationship). The X-ray response intensity was examined and collected by a Hamamatsu R928 PMT. The radiation dose rate of the X-ray source was calibrated by using RaySafe 452 dosimeter. The pulse height spectra of <sup>137</sup>Cs were collected using a standard bialkali Hamamatsu R2059 photomultiplier tube connected to a Canberra 2005 pre-amplifier, Ortec 672 spectroscopy amplifier, and a Tukan 8K multichannel analyzer. A shaping time of 10 μs was used to ensure complete light collection. The absolute light yield in photons per MeV was measured via the single photoelectron technique using a factory-measured quantum efficiency R2059 PMT.

To determine the Limit of detection (LOD), a series of the background signals were recorded without the sample under X-ray irradiation under 3.08 to 221.39 to 3.08 μGy s<sup>-1</sup> measurement. Then, a series of signal responses were taken with the sample under the above conditions, and the slope was determined. The LOD was calculated using the equation below, where  $Bk_{std}$  is the standard deviation of the background responses.

$$LOD = \frac{3 * Bk_{std}}{Slope} \dots\dots\dots(5)^1$$

**X-ray imaging**

The X-ray imaging system is a lab-built X-ray imaging system comprising of an X-ray, sample holder, light ray reflector, and a digital camera. The X-ray source used in the imaging was a Moxtek Mini-X tube with a W target and 4 W maximum power output. In this built imaging system, the X-ray beam passed vertically through the object of interest, and the scintillator film, right below it. The optical path of resulting radioluminescence was then deflected towards the camera by a reflector angled at the imaging system to remove the negative effect caused by direct X-ray irradiation of the camera. A digital camera was used to capture the deflected image and save it in jpeg format.

Table S1. Single crystal structure data of (TPA-PD)<sub>2</sub>ZnCl<sub>2</sub>

	<b>(TPA-PD)<sub>2</sub>ZnCl<sub>2</sub></b>
<b>Compound</b>	(C <sub>23</sub> H <sub>18</sub> N <sub>2</sub> ) <sub>2</sub> ZnCl <sub>2</sub>
<b>CCDC number</b>	2181767
<b>Empirical formula</b>	C <sub>46</sub> H <sub>36</sub> N <sub>4</sub> ZnCl <sub>2</sub>
<b>Molecular weight/g/mole</b>	781.06
<b>Temperature/K</b>	150
<b>Crystal system</b>	Monoclinic
<b>Space group</b>	P2 <sub>1</sub> /c
<b>a/Å</b>	21.9901(3)
<b>b/Å</b>	11.7699(2)
<b>c/Å</b>	15.3428(2)
<b>α/°</b>	90
<b>β/°</b>	106.6460(2)
<b>γ/°</b>	90
<b>Volume/Å<sup>3</sup></b>	3804.63(12)
<b>Z</b>	4
<b>P<sub>calc</sub> g/cm<sup>3</sup></b>	1.364
<b>F (000)</b>	1616.0
<b>H<sub>max</sub>, k<sub>max</sub>, l<sub>max</sub></b>	27,14,19
<b>T<sub>min</sub>, T<sub>max</sub></b>	0.059,0.620
<b>μ/mm<sup>-1</sup></b>	2.483
<b>R<sub>1</sub>, wR<sub>2</sub></b>	0.0487 <sup>a</sup> , 0.1378 <sup>b</sup>
<b>Goodness-of-fit on F<sup>2</sup></b>	1.085

a)  $R_1 = \sum ||F_o| - |F_c|| / \sum |F_o|$ . b)  $wR_2 = [\sum w(F_o^2 - F_c^2)^2 / \sum w(F_o^2)^2]^{1/2}$

Table S2. Selected bond distance and angles of (TPA-PD)<sub>2</sub>ZnCl<sub>2</sub>.

Bonds	Angle (°)
Cl <sub>1</sub> -Zn <sub>1</sub> -Cl <sub>2</sub>	122.19
Cl <sub>1</sub> -Zn <sub>1</sub> -N <sub>1</sub>	107.23
Cl <sub>1</sub> -Zn <sub>1</sub> -N <sub>3</sub>	105.50
Cl <sub>2</sub> -Zn <sub>1</sub> -N <sub>1</sub>	107.99
N <sub>1</sub> -Zn <sub>1</sub> -N <sub>3</sub>	104.33
Zn1-N1-C <sub>24</sub>	121.2
Zn <sub>1</sub> -N <sub>1</sub> -C <sub>28</sub>	120.1
Bonds	Distance (Å)
Zn <sub>1</sub> -Cl <sub>1</sub>	2.23
Zn <sub>1</sub> -Cl <sub>2</sub>	2.24
Zn1-N1	2.05
Zn <sub>1</sub> -N <sub>3</sub>	2.04

Table S3. Fitting parameters for PL decay kinetics of BBPZn, TPA-PD, and (TPA-PD)<sub>2</sub>ZnCl<sub>2</sub>.

	A <sub>1</sub>	τ <sub>1</sub> (ns)	A <sub>2</sub>	τ <sub>2</sub> (ns)	τ <sub>avg</sub> (ns)

<b>BBPZn</b>	1.0000	4.0036			4.00
<b>TPA-PD</b>	0.6816	0.9657	0.3184	2.9245	1.59
<b>(TPA-PD)<sub>2</sub>ZnCl<sub>2</sub></b>	0.8388	1.1588	0.1612	4.1841	1.81

Table S4. A figure of merit for reported scintillators based on metal-organic complexes.

<b>S/N</b>	<b>Material</b>	<b>Light yield (Photon/MeV)</b>	<b>Decay lifetime (ns)</b>	<b>LOD (nGyS<sup>-1</sup>)</b>	<b>Ref</b>
<b>1</b>	CP1	21037	8.47× 10 <sup>6</sup> (PL)	34.45	<sup>1</sup>
<b>2</b>	CP2	10580	4.36× 10 <sup>6</sup> (PL)	62.64	<sup>1</sup>
<b>3</b>	CP3	13470	2.31× 10 <sup>6</sup> (PL)	45.02	<sup>1</sup>
<b>4</b>	(DXP) <sub>2</sub> MnBr	18 400	8.01× 10 <sup>6</sup> (PL)	65.1	<sup>2</sup>
<b>5</b>	Tb-TPC	5453	1.34× 10 <sup>5</sup> (PL)	1114	<sup>3</sup>
<b>6</b>	Eu-TPC	6121	4.63× 10 <sup>5</sup> (PL)	520	<sup>3</sup>
<b>7</b>	CeCl <sub>3</sub> -Bu	1920	NA	NA	<sup>4</sup>
<b>8</b>	CeBr <sub>3</sub> -Prop	3218	NA	NA	<sup>4</sup>
<b>9</b>	Tb-1	4800	7.64 × 10 <sup>5</sup> (PL)	243	<sup>5</sup>
<b>10</b>	Passivated -Tb-1	9000	NA	146	<sup>5</sup>
<b>12</b>	BBPZn	6249	4.00 (PL) 6.78 (RL)	15.56	This work
<b>13</b>	(TPA-PD) <sub>2</sub> ZnCl <sub>2</sub>	13 423	1.81 (PL) 5.24 (RL)	80.23	This work

Table S5. Experimental dose rate.

<b>S/N</b>	<b>Dose rate (μgray/sec)</b>	<b>Voltage (kV)</b>	<b>Current (μA)</b>
<b>1</b>	221.39	40	100

<b>2</b>	210.56	40	95
<b>3</b>	199.44	40	90
<b>4</b>	188.06	40	85
<b>5</b>	177.22	40	80
<b>6</b>	166.11	40	75
<b>7</b>	155.00	40	70
<b>8</b>	143.89	40	65
<b>9</b>	132.78	40	60
<b>10</b>	121.67	40	55
<b>11</b>	110.83	40	50
<b>12</b>	99.72	40	45
<b>13</b>	88.61	40	40
<b>14</b>	77.5	40	35
<b>15</b>	66.38	40	30
<b>16</b>	55.28	40	25
<b>17</b>	44.17	40	20
<b>18</b>	31.39	35	20
<b>19</b>	19.14	30	20
<b>20</b>	9.03	25	20
<b>21</b>	3.08	20	20

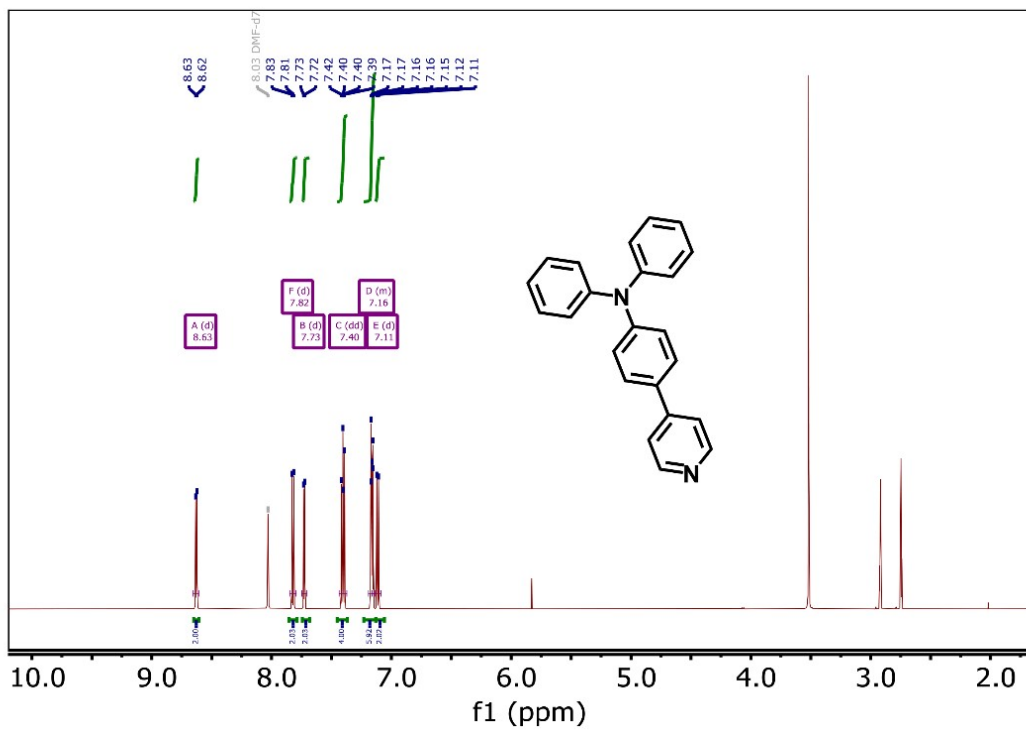


Figure S1. NMR characterization of TPA-PD.  $^1\text{H}$  NMR of TPA-PD.

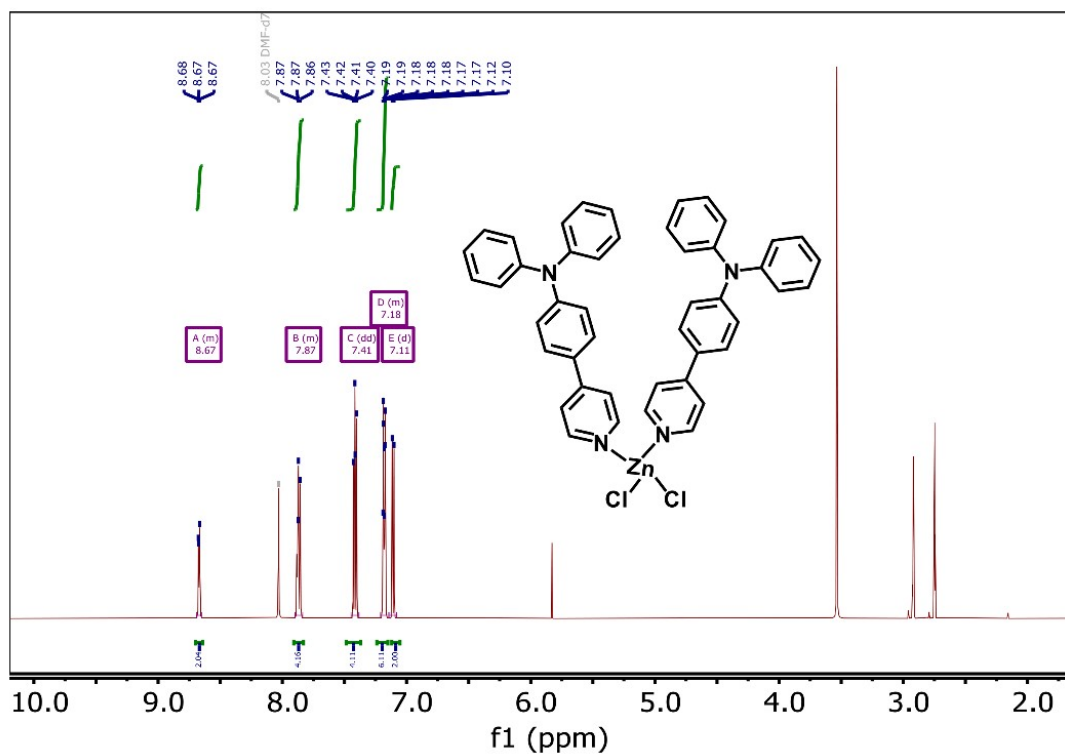


Figure S2. NMR characterization of  $(\text{TPA-PD})_2\text{ZnCl}_2$ .  $^1\text{H}$  NMR of  $(\text{TPA-PD})_2\text{ZnCl}_2$ .



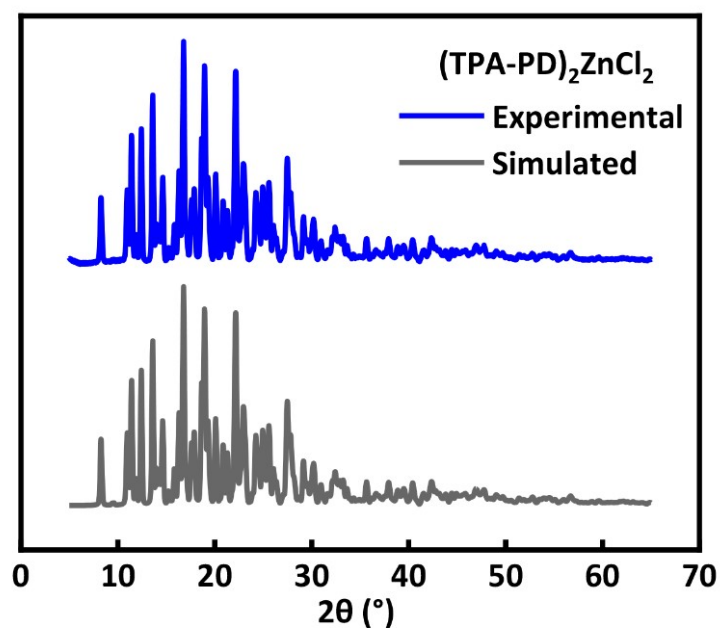


Figure S3. PXRD of  $(\text{TPA-PD})_2\text{ZnCl}_2$ . Comparison between the experimental and simulated PXRD Patterns of  $(\text{TPA-PD})_2\text{ZnCl}_2$ .

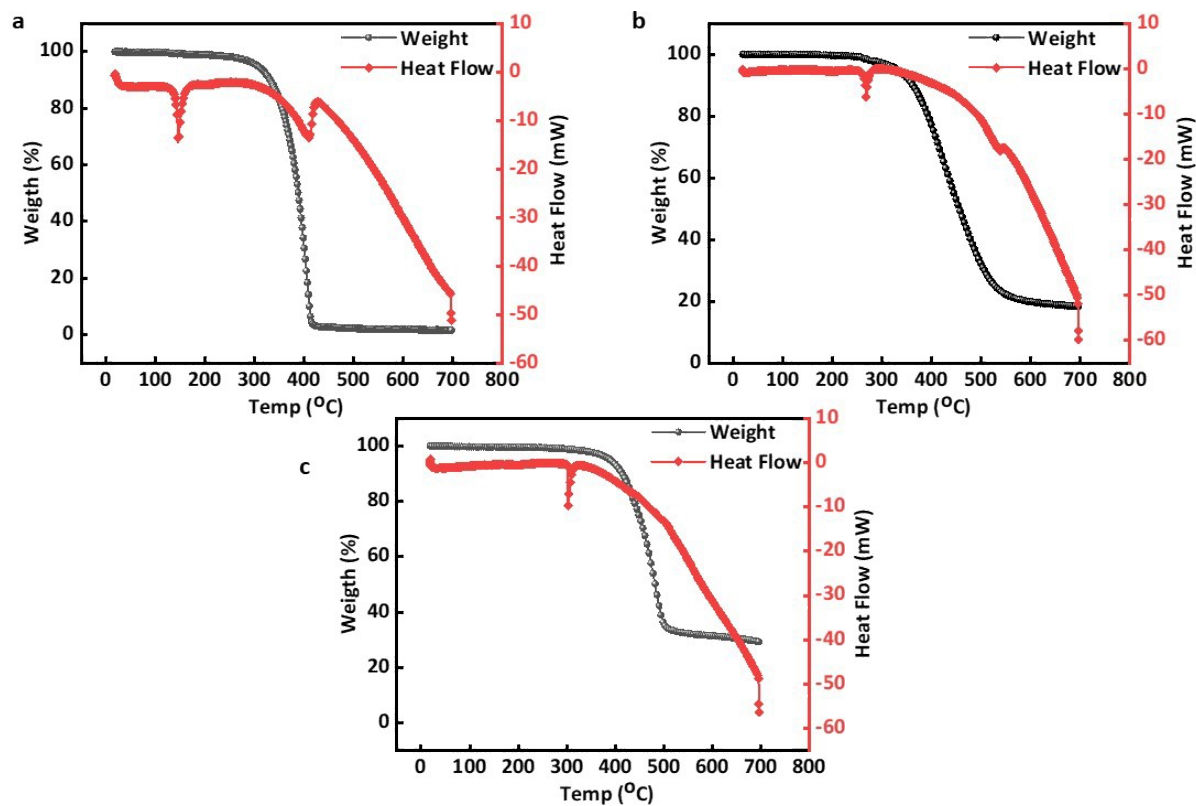


Figure S4. Thermal analysis. Thermogravimetric and differential scanning calorimetric analysis of a) TPA-PD; b)  $(\text{TPA-PD})_2\text{ZnCl}_2$ ; (c) BBPZn.

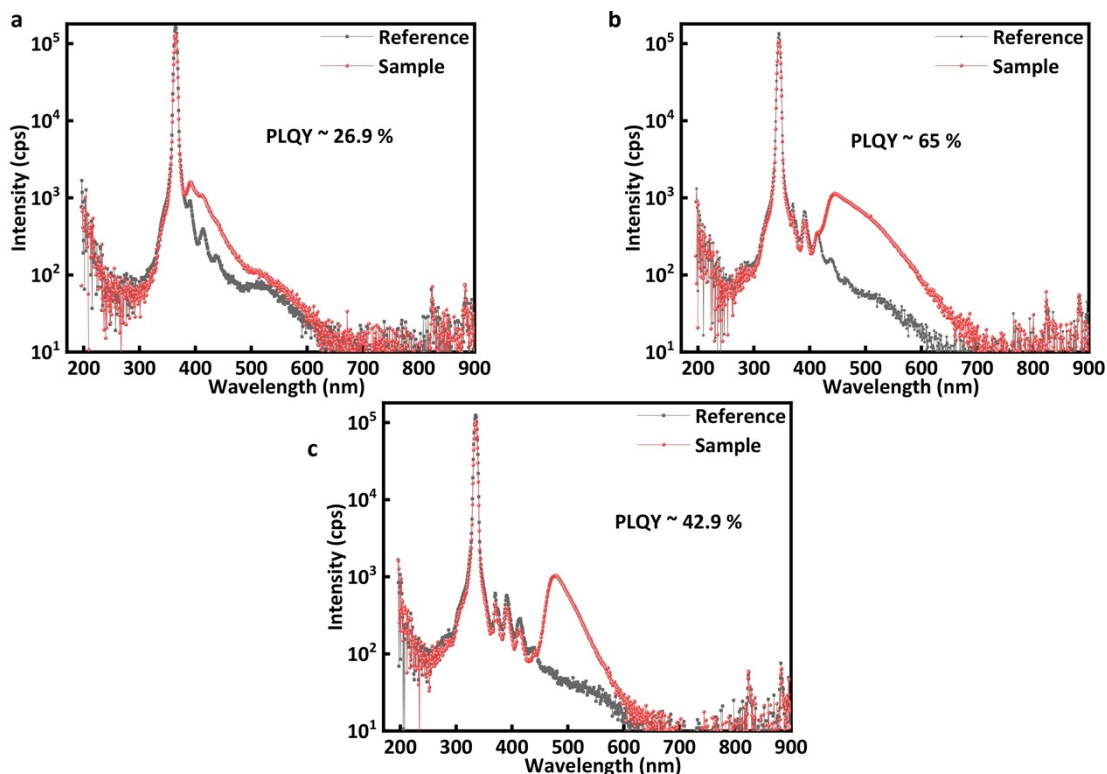


Figure S5. Photophysical Characterization. Photoluminescence Quantum Yields of; (a) TPA-PD; (b)  $(\text{TPA-PD})_2\text{ZnCl}_2$ ; and (c) BBPZn.

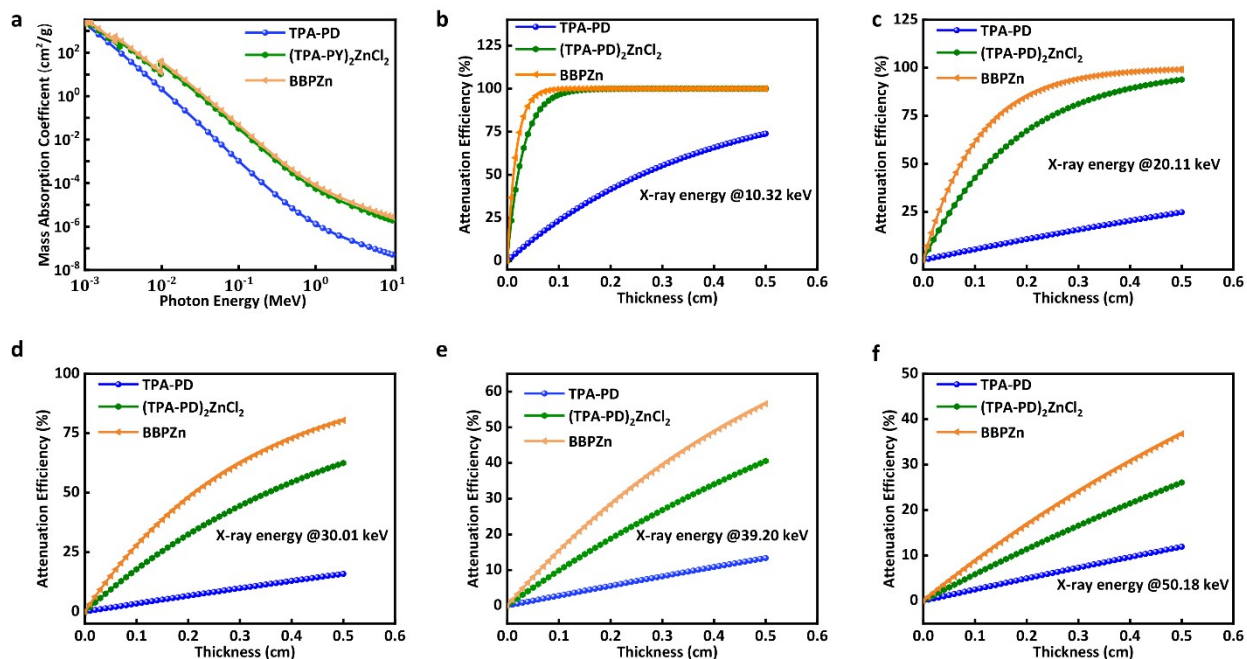


Figure S6. Computed high-energy radiation absorption. (a) Mass absorption coefficient vs photon energy plot of TPA-PD,  $(\text{TPA-PD})_2\text{ZnCl}_2$  and BBPZn; (b, c, d, e) X-ray Energy (10.32 KeV, 20.11 KeV, 30.01 keV, 39.20 keV and 50.18 keV respectively) efficiency vs thickness of TPA-PD,  $(\text{TPA-PD})_2\text{ZnCl}_2$ , and BBPZn.

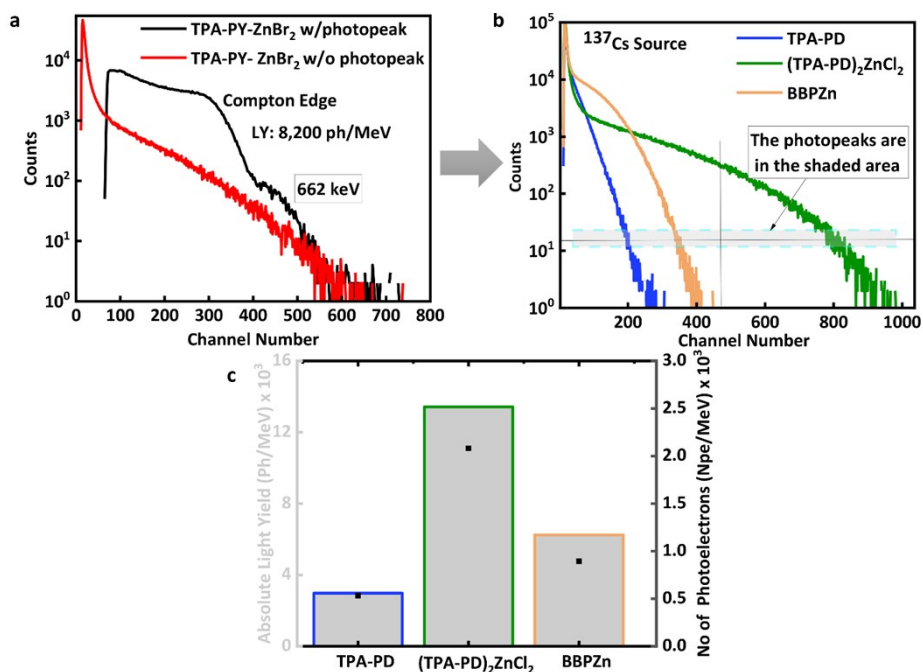


Figure S7. Absolute light yield measurement. (a) Counts vs Channel plot of (TPA-PD)<sub>2</sub>ZnBr<sub>2</sub> with <sup>137</sup>Cs excitation source (b) Counts vs Channel plot of TPA-PD, (TPA-PD)<sub>2</sub>ZnCl<sub>2</sub> and BBPZn with <sup>137</sup>Cs excitation source; (c) Absolute light and number of photoelectrons bar chart of TPA-PD, (TPA-PD)<sub>2</sub>ZnCl<sub>2</sub>, and BBPZn.

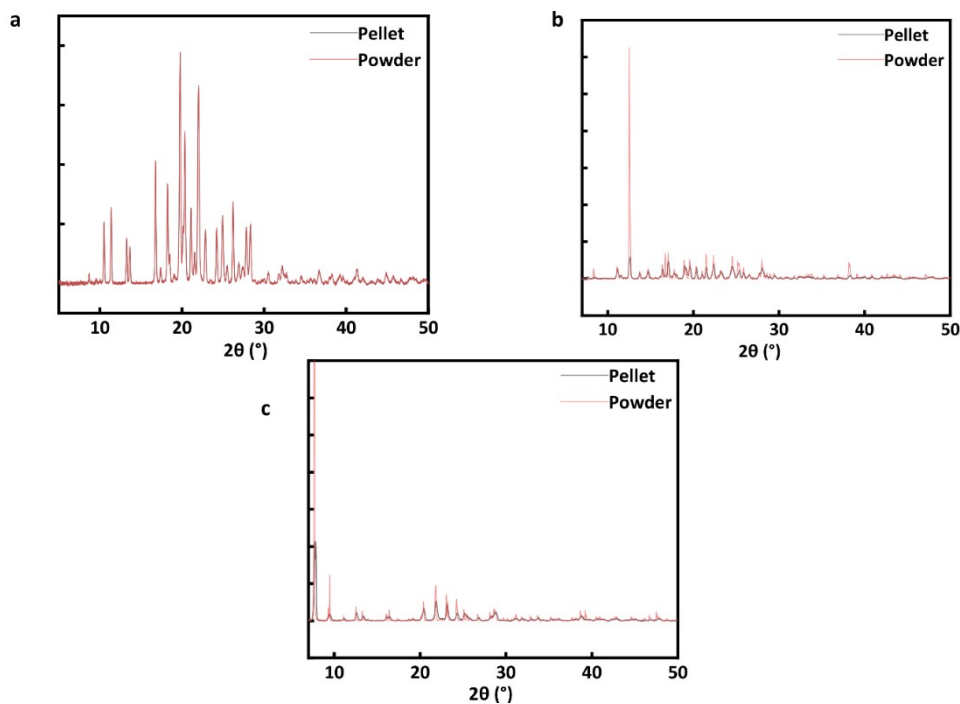


Figure S8. Powder X-ray Diffraction (PXRD). PXRD data comparison of pellet and powder of (a) TPA-PD; (b) (TPA-PD)<sub>2</sub>ZnCl<sub>2</sub>; (c) BBPZn.

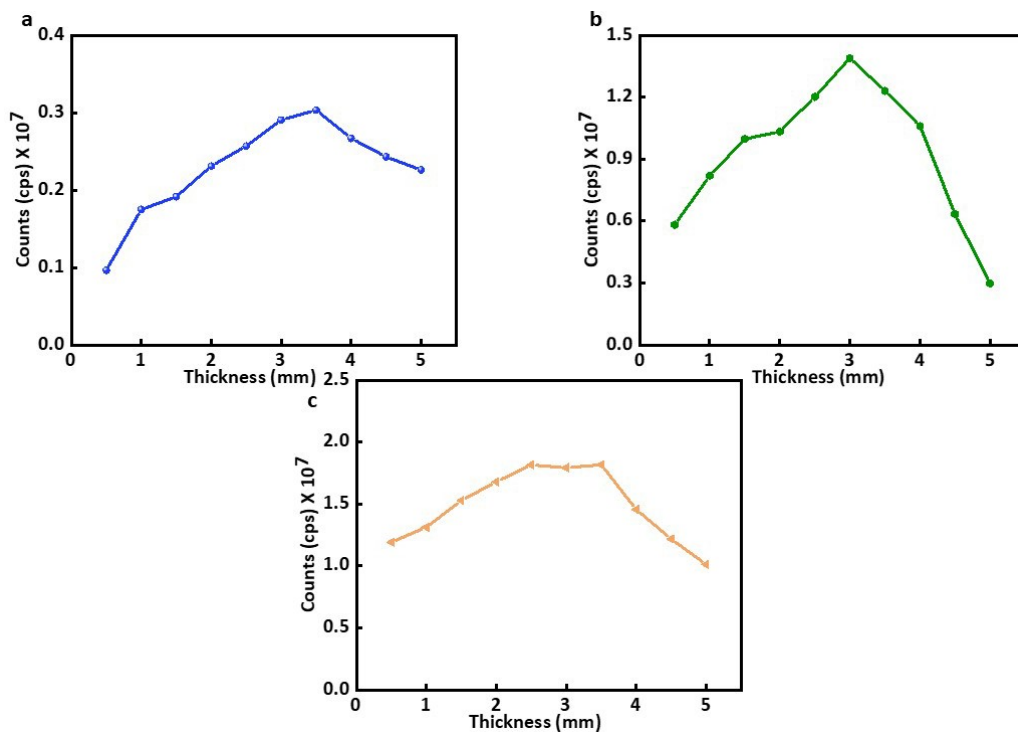


Figure S9. Thickness-dependent radioluminescence. Integrated radioluminescence of (a) TPA-PD; (b) (TPA-PD)<sub>2</sub>ZnCl<sub>2</sub>; (c) BBPZn at different thicknesses.

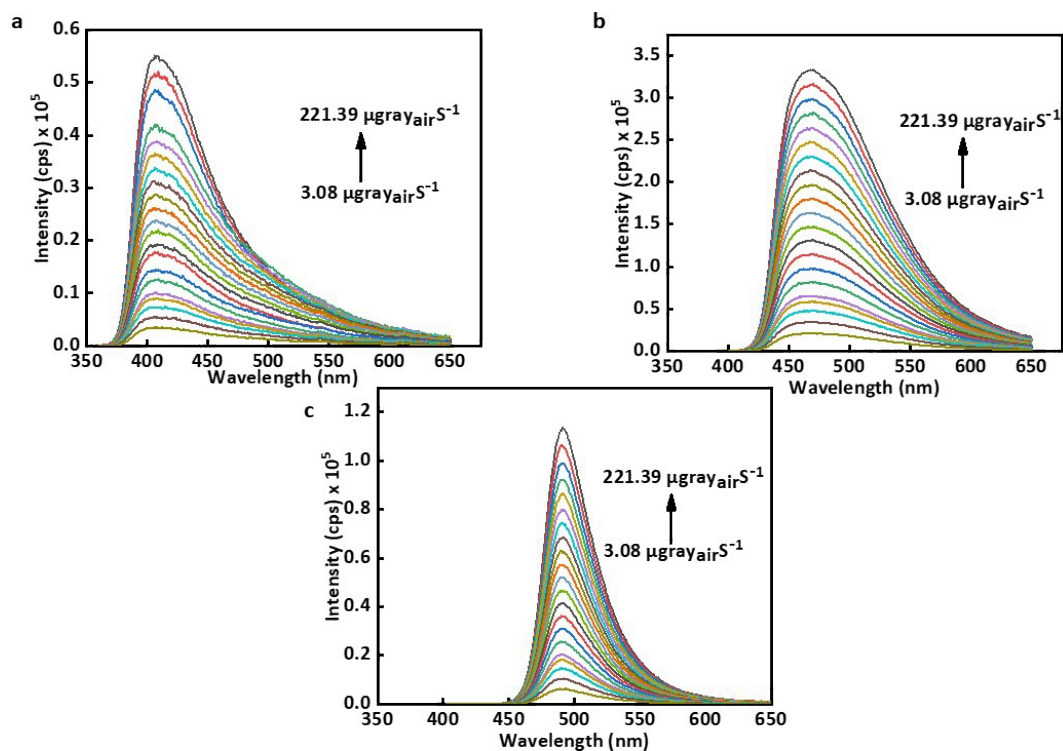


Figure S10. Dose-Response. Radioluminescence spectra of under X-ray excitation dose rate from 221.39 to 3.08 μGy<sub>air</sub> s<sup>-1</sup> of: (a) TPA-PD; (b) (TPA-PD)<sub>2</sub>ZnCl<sub>2</sub>; (c) BBPZn.

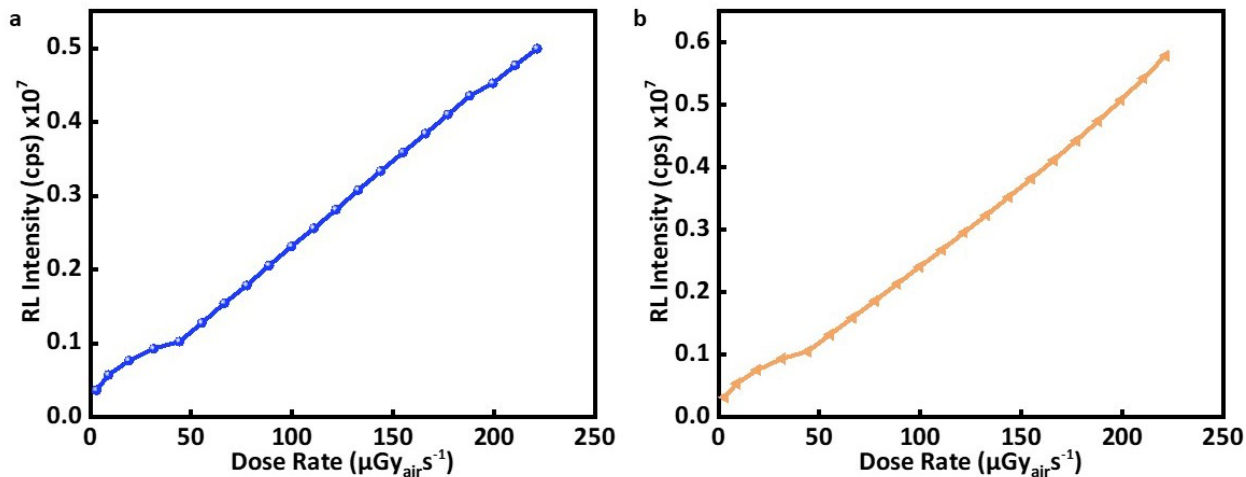


Figure S11. Dose-Response. Integrated radioluminescence spectra under X-ray excitation dose rate from 221.39 to 3.08  $\mu\text{Gy}_{\text{air}}\text{s}^{-1}$  of; (a)TPA-PD; (b) BBPZn.

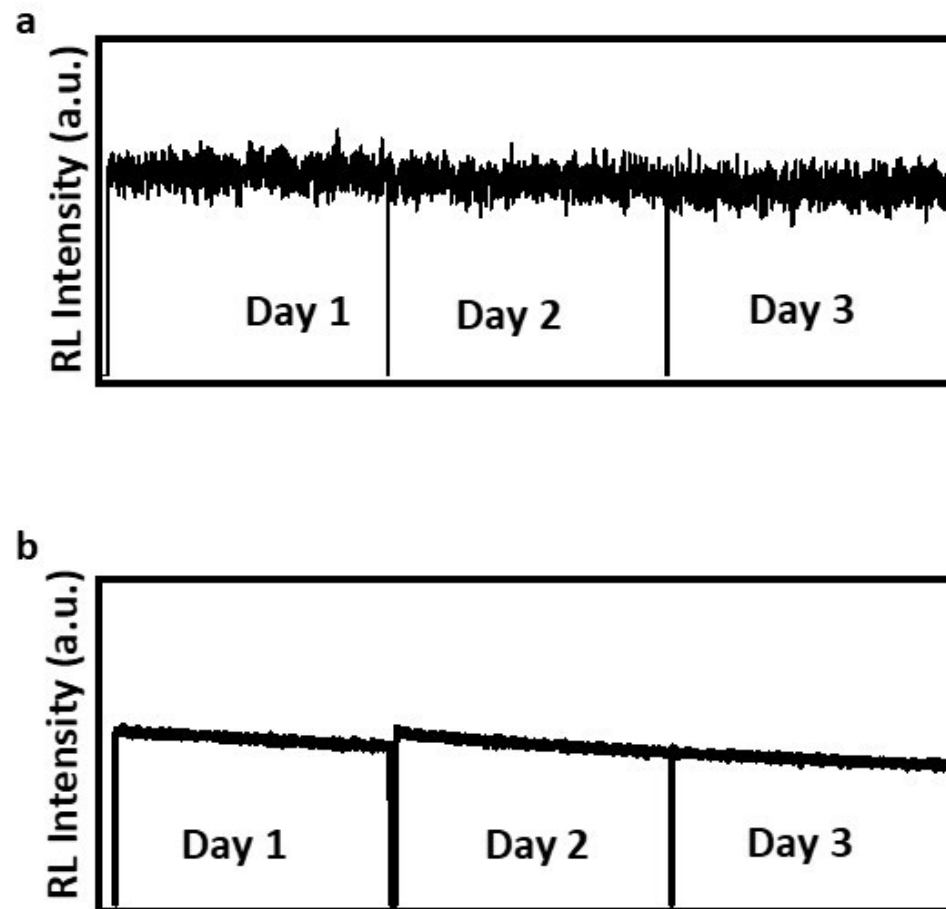


Figure S12. Radio-stability. Radiation stability under continuous irradiation ( $221.39 \mu\text{Gy}_{\text{air}}\text{s}^{-1}$ ) for 30 mins for Day 1, Day 2 and Day 3 of; (a) TPA-PD; (b) BBPZn.

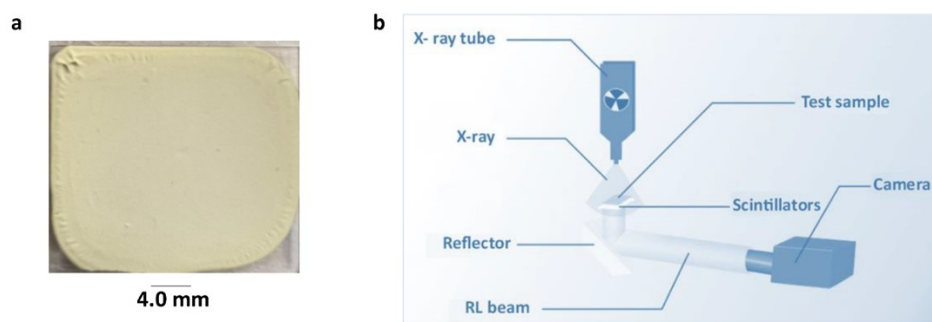


Figure S13. (a) 60 wt% (TPA-PD)<sub>2</sub>ZnCl<sub>2</sub> - PMMA composite; (b) Schematic of lab-built X-ray imaging setup.

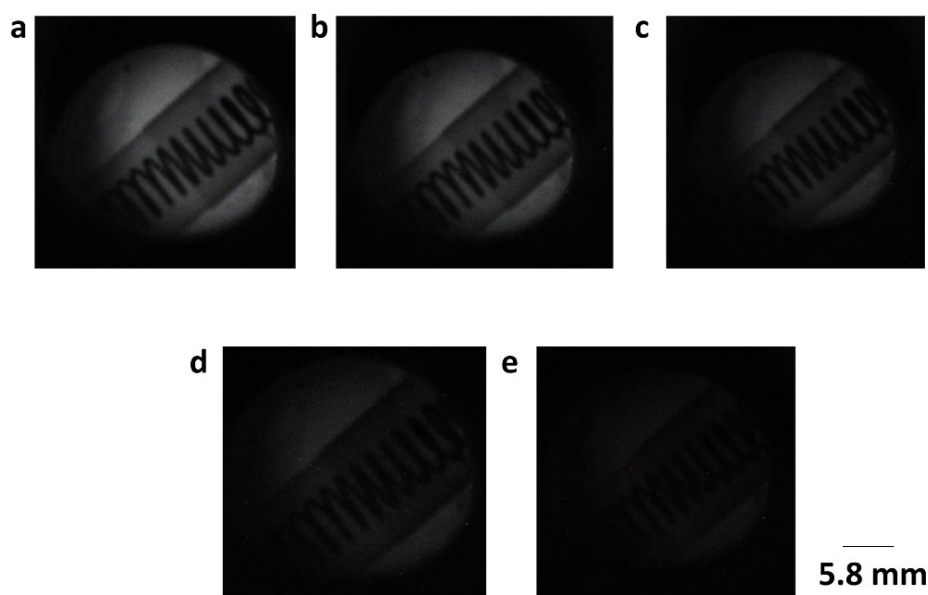


Figure S14. X-ray Images of encapsulated spring under various X-ray dose rates. X-ray images under; (a) 40 kV, 100 $\mu$ A; (b) 40 kV, 60  $\mu$ A; (c) 40 kV, 40  $\mu$ A; (d) 20 kV, 100 $\mu$ A; (e) 40 kV, 20  $\mu$ A X-ray irradiation

## References

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